## Notice of References Cited Application/Control No. 10/517,158 Applicant(s)/Patent Under Reexamination PADE, WOLFGANG Examiner Gary F. Paumen Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,713,760	02-1998	Chemin, Gilles	439/595
*	В	US-6,761,590	07-2004	Maue et al.	439/620
*	С	US-6,863,568	03-2005	Nakamura, Keiichi	439/595
*	D	US-2005/0090148	04-2005	Sagawa et al.	439/595
*	Ε	US-2005/0085126	04-2005	Sagawa et al.	439/595
*	F	US-2004/0171317	09-2004	Finzer et al.	439/752
*	G	US-2002/0168896	11-2002	Suzuki, Kenji	439/595
*	Н	US-6,945,829	09-2005	Finzer et al.	439/752
*	1	US-6,716,069	04-2004	Nakamura et al.	439/752
*	J	US-6,685,506	02-2004	Nakamura et al.	439/595
*	К	US-6,682,367	01-2004	Suzuki, Kenji	439/595
*	L	US-6,648,699	11-2003	Makino et al.	439/752
*	М	US-6,155,888	12-2000	Kurimoto, Naoya	439/752

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	8	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.